

UNISONIC TECHNOLOGIES CO., LTD

UT140N10H Preliminary

Power MOSFET

140A, 100V N-CHANNEL POWER MOSFET

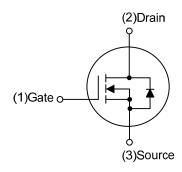
DESCRIPTION

The UTC **UT140N10H** is a N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

FEATURES

- * $R_{DS(ON)} \le 7.0 \text{ m}\Omega$ @ $V_{GS}=10V$, $I_D=70A$
- * Improved dv/dt capability
- * High Switching Speed
- * Fast switching

SYMBOL

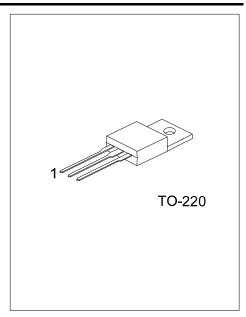


ORDERING INFORMATION

Ordering Number		D1	Pin Assignment			Da aldin ii	
Lead Free	Halogen Free	Package	1	2	3	Packing	
UT140N10HL-TA3-T	UT140N10HG-TA3-T	TO-220	G	D	S	Tube	

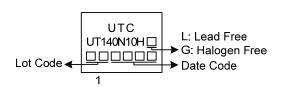
Note: Pin Assignment: G: Gate D: Drain S: Source

UT140N10HG-TA3-T
(1)Packing Type (1) T: Tube
(2)Package Type (2) TA3: TO-220
(3)Green Package (3) G: Halogen Free and Lead Free L: Lead Free



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MARKING



■ ABSOLUTE MAXIMUM RATINGS (T_C=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		V_{DSS}	100	V	
Gate-Source Voltage		V_{GSS}	±20	V	
Drain Current	Continuous (V _{GS} =10V)	I_D	140	Α	
	Pulsed (Note 2)	I_{DM}	280	Α	
Avalanche Energy	Single Pulsed (Note 3)	E _{AS}	723	mJ	
Peak Diode Recovery dv/dt (Note 4)		dv/dt	5	V/ns	
Power Dissipation		P_{D}	282	W	
Junction Temperature		T_J	+150	°C	
Storage Temperature		T_{STG}	-55 ~ + 150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L = 0.1mH, I_{AS} = 120A, V_{DD} = 50V, R_G = 25 Ω , Starting T_J = 25 $^{\circ}$ C
- 4. $I_{SD} \le 30A$, $di/dt \le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, $T_J \le T_{JMAX}$, $T_J = 25$ °C.

■ THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT	
Junction to Ambient	θ_{JA}	62.5	°C/W	
Junction to Case	θ_{JC}	0.44	°C/W	

■ ELECTRICAL CHARACTERISTICS (T_J=25°C, unless otherwise specified)

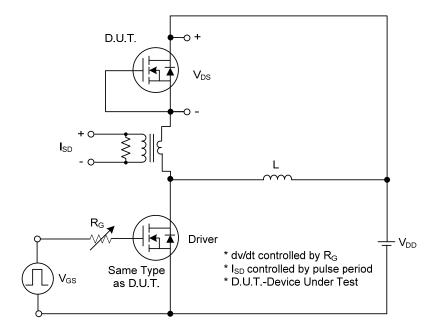
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV_DSS	V_{GS} =0 V , I_D =250 μ A	100			V
Drain-Source Leakage Current	I _{DSS}	V _{DS} =100V, V _{GS} =0V			1	μΑ
Forward	I _{GSS}	V _{GS} =+20V, V _{DS} =0V			+100	nA
Gate- Source Leakage Current Reverse		V _{GS} =-20V, V _{DS} =0V			-100	nA
ON CHARACTERISTICS						
Gate Threshold Voltage	$V_{GS(TH)}$	V _{DS} =V _{GS} , I _D =250µA	2.0		4.0	V
Static Drain-Source On-State Resistance	R _{DS(ON)}	V_{GS} =10V , I_D =70A			7.0	mΩ
DYNAMIC PARAMETERS						
Input Capacitance	C _{ISS}			16		nF
Output Capacitance	Coss	V _{GS} =0V, V _{DS} =25V, f=1.0MHz		948		pF
Reverse Transfer Capacitance	C_{RSS}			758		pF
SWITCHING PARAMETERS						
Total Gate Charge	Q_G	V _{DS} =80V, V _{GS} =10V, I _D =140A (Note 1,2)		417		nC
Gate to Source Charge	Q_GS			74		nC
Gate to Drain Charge	Q_GD	(Note 1,2)		210		nC
Turn-ON Delay Time	$t_{D(ON)}$			43		ns
Rise Time	t_R	V _{DD} =50V, V _{GS} =10V, I _D =140A,		38		ns
Turn-OFF Delay Time	$t_{D(OFF)}$	R _G =3Ω, (Note1, 2)		187		ns
Fall-Time	t _F			75		ns
SOURCE- DRAIN DIODE RATINGS AND O	CHARACTERI	STICS				
Maximum Continuous Drain-Source Diode					140	^
Forward Current	Is				140	Α
Maximum Pulsed Drain-Source Diode	I _{SM}				280	Α
Forward Current					200	Α
Drain-Source Diode Forward Voltage	V_{SD}	I _S =140A,V _{GS} =0V			1.4	V
Body Diode Reverse Recovery Time	t _{rr}	I _S =30A, dI/dt=100A/µs		120		ns
Body Diode Reverse Recovery Charge	Q_{rr}	IIS-30A, UI/UL-100A/µS		543		nC

Notes: 1. Pulse Test: Pulse width \leq 300µs, Duty cycle \leq 2%.

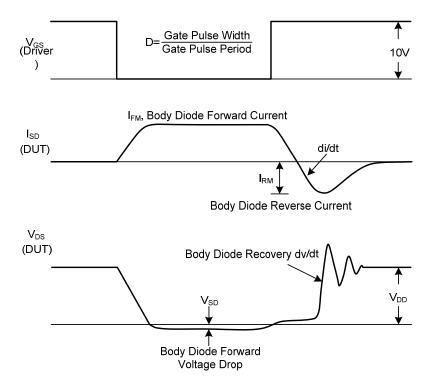
2. Essentially independent of operating ambient temperature.



■ TEST CIRCUITS AND WAVEFORMS

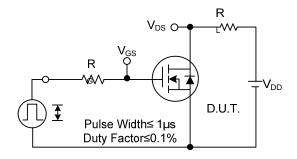


Peak Diode Recovery dv/dt Test Circuit

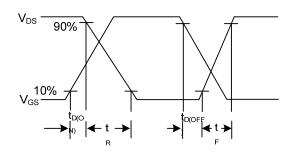


Peak Diode Recovery dv/dt Waveforms

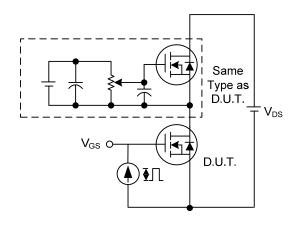
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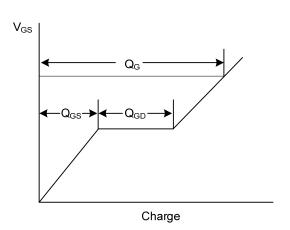
Switching Test Circuit



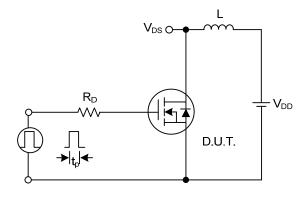
Switching Waveforms



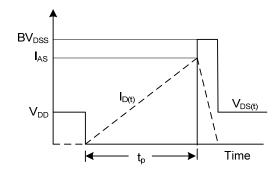
Gate Charge Test Circuit



Gate Charge Waveform



Unclamped Inductive Switching Test Circuit



Unclamped Inductive Switching Waveforms

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